TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2445

Chopper Regulator, DC-DC Converter and Motor Drive Applications

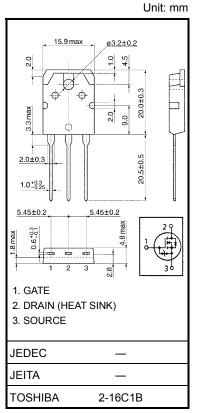
Low drain-source ON resistance : RDS (ON) = 14 mΩ (typ.)
 High forward transfer admittance : |Yfs| = 40 S (typ.)

• Low leakage current : $IDSS = 100 \mu A (max) (VDS = 60 V)$

• Enhancement mode $V_{th} = 1.5 \sim 3.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA}$

Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	60	٧	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	50	Α	
	Pulse (Note 1)	I _{DP}	200	Α	
Drain power dissipatio	n (Tc = 25°C)	P _D	125	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	683	mJ	
Avalanche current		I _{AR}	50	А	
Repetitive avalanche	energy (Note 3)	E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature r	ange	T _{stg}	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 25 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 371 μH , $R_{G} = 25 \Omega$, $I_{AR} = 50 \text{ A}$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



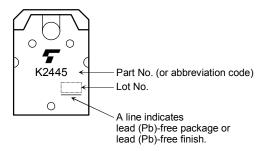
Electrical Characteristics (Ta = 25°C)

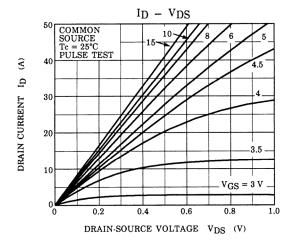
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br voltage	reakdown	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V
Gate threshold	/oltage	V_{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.0	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 25 A		14	18	mΩ
Forward transfe	r admittance	Y _{fs}	V _{DS} = 15 V, I _D = 25 A	28	40	_	S
Input capacitano	ce	C _{iss}		_	3350	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		550	_	pF
Output capacitance		Coss]		1600	-	
Switching time	Rise time	t _r	VGS OV I I VOUT	_	25	_	
	Turn-on time	t _{on}	$\begin{array}{c c} & & & \\ & & & \\ & & \\ & & \\ \end{array} \begin{array}{c} & \\ & \\ \end{array} \begin{array}{c} \\ & \\ \end{array} \begin{array}{c} \\ \\ \\ \end{array} \begin{array}{c} \\ \\ \end{array} \begin{array}{c} \\ \\ \\ \end{array} \begin{array}{c} \\ \\ \end{array} \begin{array}{c} \\ \\ \\ \end{array} \begin{array}{c} \\ \\ \end{array} \begin{array}{c} \\ \\ \\ \\ \end{array} \begin{array}{c} \\ \\ \\ \end{array} \begin{array}{c} \\ \\ \\ \\ \\ \\ \end{array} \begin{array}{c} \\\\ \\ \\ \\ \\ \end{array} \begin{array}{c} \\\\ \\\\ \\ \\ \\ \end{array} \begin{array}{c} \\\\ \\\\ \\ \\ \\ \end{array} \begin{array}{c} \\\\ \\\\ \\\\ \\ \end{array} \begin{array}{c} \\\\\\ \\\\ \\\\ \\\\ \end{array} \begin{array}{c} \\$	_	55	_	ns
	Fall time	t _f		_	60	_	
	Turn-off time	t _{off}	$V_{DD} = 30V$ Duty $\leq 1\%$, $t_{W} = 10 \mu s$	_	180	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	110	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		70	_	nC
Gate-drain ("miller") charge		Q _{gd}			40	_	

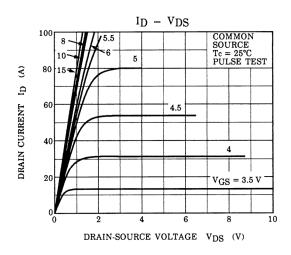
Source-Drain Ratings and Characteristics (Ta = 25°C)

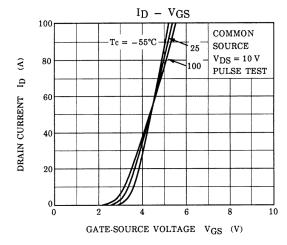
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	-	_	_	50	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	200	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 50 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 50 A, V _{GS} = 0 V, dI _{DR} / dt = 50 A / μs	_	120	_	ns
Reverse recovery charge	Qrr	1DK - 30 Λ, VGS - 0 V, αιDK / αι - 30 Λ / μs	- 1	0.2	_	μC

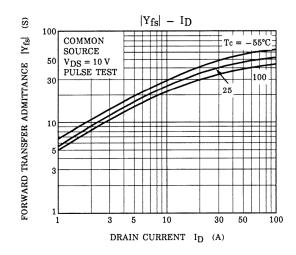
Marking

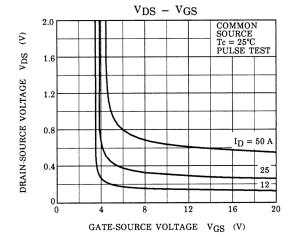


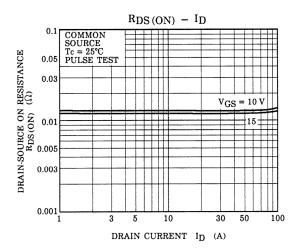


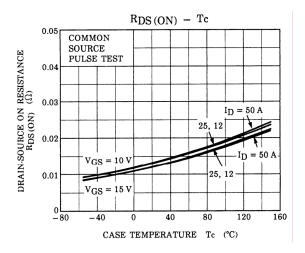


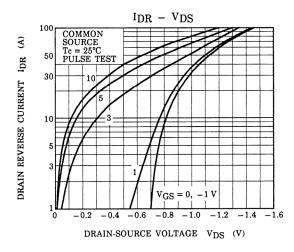


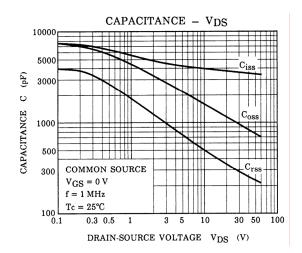


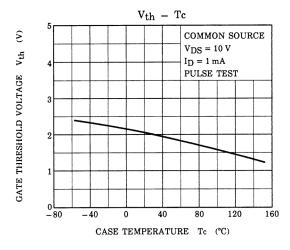


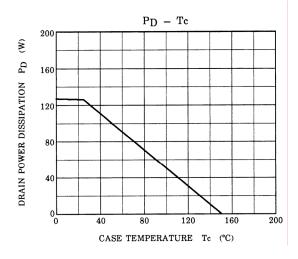


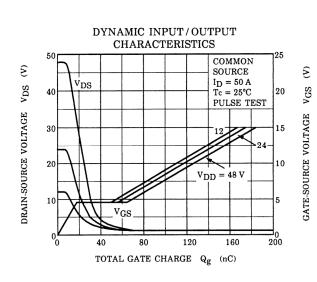




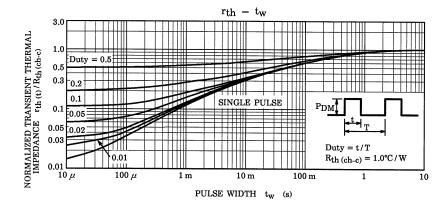


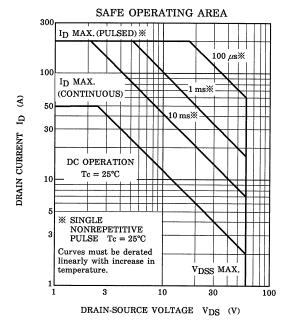


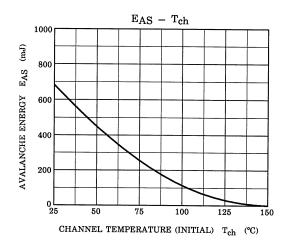


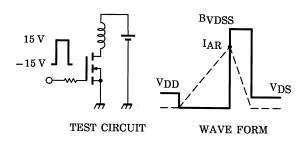


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$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 25~V,~L = 371~\mu H \end{aligned} \qquad E_{AS} &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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